

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	0	(error near code) with (defect near (type and (address location)))"0"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/21 14:54
		((nonvolatile "non-volatile") near\$2 memor\$3) same ((redundant spare) near\$2 (cell\$2 memor\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/09/08 17:38
		2005/0021635	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/22 16:23
L2	0	2005/0021635.pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/22 16:23
L3	0	"0021635".pn.	US-PGPUB	OR	ON	2006/02/22 16:23
L4	0	"0021635"	US-PGPUB	OR	ON	2006/02/22 16:23
L5	1	"20050021635"	US-PGPUB	OR	ON	2006/02/22 16:24
S1	7	(flash near memory) and ((rudundant spare) near (cell memory)) and (error near code)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/22 14:18
S2	15	((("non-volatile" nonvolatile) near memory) and ((rudundant spare) near (cell memory)) and (error near cod\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/24 10:24
S3	38	((("non-volatile" nonvolatile) near\$4 memory) and ((rudundant spare) near (cell memory)) and (error near cod\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/21 13:56
S4	7	(flash near memory) and ((rudundant spare) near (cell memory)) and (error near code)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/21 13:56

EAST Search History

S5	31	((("non-volatile" nonvolatile) near\$4 memory) and ((rudundant spare) near (cell memory)) and (error near cod\$3)) not ((flash near memory) and ((rudundant spare) near (cell memory)) and (error near code))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/21 13:56
S6	0	"09838764"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/22 14:18
S7	16	"838764"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/22 14:18
S8	3	"838764"	US-PGPUB	OR	ON	2004/06/22 14:18
S9	68	((("non-volatile" nonvolatile) near memory) and ((rudundant spare) near (cell memory)) and (fuse near circuit\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/24 10:25
S10	0	((("non-volatile" nonvolatile) near memory) and ((rudundant spare) near (cell memory)) and (fuse near circuit\$3)).ab. (((("non-volatile" nonvolatile) near memory) and ((rudundant spare) near (cell memory)) and (fuse near circuit\$3)).ti. (((("non-volatile" nonvolatile) near memory) and ((rudundant spare) near (cell memory)) and (fuse near circuit\$3)).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/24 10:26
S11	2874491	((nonvolatile "non-volatile") near\$2 memor\$3) with ((redundant spare) near\$2 (cell\$2 memor\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/06/24 10:29
S12	13178	((((nonvolatile "non-volatile") near\$2 memor\$3) same ((redundant spare) near\$2 (cell\$2 memor\$3))) and (error near cod\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/06/24 10:31
S13	16	((((nonvolatile "non-volatile") near memor\$3) same ((redundant spare) near (cell\$2 memor\$3))) and (error near cod\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/06/24 10:31

EAST Search History

S14	13178	((nonvolatile "non-volatile") near\$2 memor\$3) same ((redundant spare) near\$2 (cell\$2 memor\$3))) and (error near cod\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/06/24 10:32
S15	2	"5359569".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/24 10:47
S16	4	("5359569" "6034891").pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/24 10:51
S17	1026	(memor\$3 with (primary and redundant))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/09 10:28
S18	313	(memor\$3 with ((primary and redundant) and (nonvolatile "non-volatile")))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/24 10:55
S19	43	(memor\$3 near ((primary and redundant) and (nonvolatile "non-volatile")))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/24 11:02
S20	5	(memor\$3 near ((primary and redundant) and (nonvolatile "non-volatile")) and (error near cod\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/24 10:55
S21	6	(memor\$3 near ((primary and redundant) same (nonvolatile "non-volatile")))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/24 11:02
S22	6	((memor\$3 near ((primary and redundant) and (nonvolatile "non-volatile"))).ab. ((memor\$3 near ((primary and redundant) and (nonvolatile "non-volatile"))).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/24 11:02
S23	49	(memory) near (defect\$3) near (type kind)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/04/20 15:35

EAST Search History

S24	74	(memory) near (defect\$3) near (type kind)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/20 15:35
S25	13	((memory) near (defect\$3) near (type kind)) and flash	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/20 15:36
S26	0	(memeory near (test\$3 redund\$4 error ecc)) and ((stor\$3 identif\$7) near defect near type)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/09 09:34
S27	0	(memeory near (test\$3 redund\$4 error ecc)) and ((stor\$3 identif\$7) with defect with type)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/09 09:34
S28	0	(memeory near (test\$3 redund\$4 error ecc)) and (defect with type)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/09 09:34
S29	670	(memory near (test\$3 redund\$4 error ecc)) and (defect with type)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/09 09:33
S30	3	(memory near (test\$3 redund\$4 error ecc)) and ((stor\$3 identif\$7) near defect near type)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/09 09:33
S31	105	(memory near (test\$3 redund\$4 error ecc)) and ((stor\$3 identif\$7) with defect with type)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/09 09:34
S32	670	(memory near (test\$3 redund\$4 error ecc)) and (defect with type)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/09 09:34
S33	105	(memory near (test\$3 redund\$4 error ecc)) and ((stor\$3 identif\$7) with defect with type)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/09 09:34

EAST Search History

S34	3	(memory near (test\$3 redund\$4 error ecc)) and ((stor\$3 identif\$7) near defect near type)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/09/09 09:34
S35	2	"6469932".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/22 16:23
S36	450	714/710.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/09/09 11:04
S37	0	(error near code) with (defect near (type and (address location)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/21 14:54
S38	0	(error near code) same (defect near (type and (address location)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/21 14:54
S39	17	(error near code) and (defect near (type and (address location)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/21 18:07
S40	17	(error near code) and (defect near (type and (address location))) and (memory)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/21 14:55
S41	6655	(memory near redundan\$4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:07
S42	48	(memory near redundan\$4) and ((row column) near short)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:07
S43	18	(memory near redundan\$4) and ((row column) near short) and erase	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:07

EAST Search History

S44	18	(memory near redundan\$4) and ((row column) near short) and eras\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:08
S45	18	(memory near redundan\$4) and ((row column) near short) and \$5eras\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:08
S46	3	((row column) near short) and \$5eras\$3 and 714/710.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:08
S47	4	((row column) near short) and \$5eras\$3 and 714/711.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:11
S48	695	((row column) near short) and \$5eras\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:11
S49	7	((row column) near short) and \$5eras\$3 and (type near defect\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:12
S50	7	((row column) near short) and \$5eras\$3 and (type near defect\$3) and error near code	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:12
S51	7	((row column) near short) and \$5eras\$3 and (type near defect\$3) and (error near code)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/22 14:03
S52	472	714/710.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:16
S53	243	714/711.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:16

EAST Search History

S54	37	714/711.ccls. and flash	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:17
S55	80	714/710.ccls. and flash	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:17
S56	50	714/710.ccls. and (type near (error defect\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:17
S57	0	714/710.ccls. and (type near (error defect\$3)) and flsh	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:17
S58	14	714/710.ccls. and (type near (error defect\$3)) and flash	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:22
S59	4	714/711.ccls. and flash and (type near (defect\$3 error))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:18
S60	149	((memory near redundan\$3) and ((error near code) (type near (error defect\$3))) and flash	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:23
S61	1	((memory near redundan\$3) and ((error near code) (type near (error defect\$3))) and flash).ab.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:23
S62	1	((memory near redundan\$3) and ((error near code) (type near (error defect\$3))) and flash).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:23
S63	18	((memory near redundan\$3) same ((error near code) (type near (error defect\$3)))) and flash	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/21 18:23

EAST Search History

S64	0	((row column) near short) and \$5eras\$3 and (type near defect\$3) and (error near code)).ab.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/22 14:04
S65	2	((row column) near short) and (memory near redundan\$4)).ab.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/22 14:05
S66	13	((row column) near short) same (memory near redundan\$4))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/02/22 14:05